

## **Search Notes**



**Application/Control No.**

10/055,197

Examiner

Jason M. Perilla

**Applicant(s)/Patent under  
Reexamination**

LIFSHITZ ET AL.

## **Art Unit**

2611

**SEARCHED**

## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
375	222	8/29/2007	JP
	295	8/29/2007	JP
	316	8/29/2007	JP

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**